

Search Notes

Application/Control No.

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Examiner

David M. Naff

Applicant(s)/Patent under
Reexamination

CHIN ET AL.

Art Unit

1651

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
<u>West</u> Geo printant	10/2/06	en